	CII IV	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/646,029	YÉH, MING-SHUAN	
Examiner	Art Unit	
Adeel Haroon	2618	

	SEARCHED		
Class	Subclass	Date	Examiner
Updated	Previous	12/18/2006	АН
		-	-
;			

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

(INCLUDING SEARCH	UIIIAI EUI	1
	DATE	EXMR
·		
•		
	-	-
•		
	•	
·		
-	<u> </u>	
·	-	